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6	0	((bar near3 code) same (read\$3 or scan\$4) and (telephone or phone)) and (bar near3 code) same (read\$3 or scan\$4) same (telephone or phone)) and (bar near3 code) same (read\$3 or scan\$4) same (telephone or phone) and (transmit\$3 or download\$3) and ((bar near3 code) same (read\$3 or scan\$4) same (telephone or phone)).ti.	USPAT	2002/08/15 13:51
7	31	((bar near3 code) same (read\$3 or scan\$4) and (telephone or phone)) and (bar near3 code) same (read\$3 or scan\$4) same (telephone or phone)) and (bar near3 code) same (read\$3 or scan\$4) same (telephone or phone) and (transmit\$3 or download\$3) and ((bar near3 code) same (read\$3 or scan\$4) same (telephone or phone)).ab.	USPAT	2002/08/15 13:47
8	1	((bar near3 code) same (read\$3 or scan\$4) same (telephone or phone)).ti.	USPAT	2002/08/15 14:32
9	4	("D408806" "D420657" "D426240" "D432539").PN.	USPAT	2002/08/15 13:51
10	33	((bar near3 code) with (read\$3 or scan\$4) same (telephone or phone)).ab.	USPAT	2002/08/15 14:03
11	172	((bar near3 code) with (read\$3 or scan\$4) same (telephone or phone)).ti.	USPAT; EPO; JPO; DERWENT; IBM TDB	2002/08/15 14:21
12	1	((bar near3 code) with (read\$3 or scan\$4) same (telephone or phone)).ti.) and (display\$3 or project\$3) and laser	USPAT; EPO; JPO; DERWENT; IBM TDB	2002/08/15 14:10
14	1	((bar near3 code) with (read\$3 or scan\$4) same (telephone or phone)).ti.) and (display\$3 or project\$3) same image	USPAT; EPO; JPO; DERWENT; IBM TDB	2002/08/15 14:16
13	28	((bar near3 code) with (read\$3 or scan\$4) same (telephone or phone)).ti.) and (display\$3 or project\$3)	USPAT; EPO; JPO; DERWENT; IBM TDB	2002/08/15 14:16
15	18165	scan\$4 and (display\$3 or project\$3) same (pixel or bit adj3 map\$3) same image	USPAT; EPO; JPO; DERWENT; IBM TDB	2002/08/15 14:18

16	481	((bar near3 code) with (read\$3 or scan\$4) and (scan\$4 and (display\$3 or project\$3) same (pixel or bit adj3 map\$3) same image))	USPAT; EPO; JPO; DERWENT; IBM_TDB	2002/08/15 14:25
17	247	((bar near3 code) with (read\$3 or scan\$4) and (scan\$4 and (display\$3 or project\$3) same (pixel or bit adj3 map\$3) same image)) and laser	USPAT; EPO; JPO; DERWENT; IBM_TDB	2002/08/15 14:26
18	111	((bar near3 code) with (read\$3 or scan\$4) and (scan\$4 and (display\$3 or project\$3) same (pixel or bit adj3 map\$3) same image)) and laser and mirror	USPAT; EPO; JPO; DERWENT; IBM_TDB	2002/08/15 14:26
19	38	((bar near3 code) with (read\$3 or scan\$4) and (scan\$4 and (display\$3 or project\$3) same (pixel or bit adj3 map\$3) same image)) and laser and mirror same (horizontal\$3 or vertical\$3)	USPAT; EPO; JPO; DERWENT; IBM_TDB	2002/08/15 14:26
20	0	D453514.URPN.	USPAT	2002/08/15 14:31
21	4	("D408806" "D420657" "D426240" "D432539").PN.	USPAT	2002/08/15 14:31
22	62	((read\$3 or scan\$4) same (cellular\$5 or telephone or phone)).ti.	USPAT	2002/08/15 14:33

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